

A Dual Channel X-ray Spectrometer for Fast Ignition Research

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ABSTRACT: A new Dual Channel Highly Ordered Pyrolytic Graphite (DC-HOPG) x-ray spectrometer was developed to study laser-generated electron beam transport. The instrument uses a pair of graphite crystals and has the advantage of simultaneously detecting self emission from low-Z materials in first diffraction order and high-Z materials in second order. The emissions from the target are detected using a pair of parallel imaging plates positioned in a such way that the noise from background is minimized and the mosaic focusing is achieved. Initial tests of the diagnostic on Titan laser ($I \sim 10^{20} \ W/cm^2$, $\tau = 0.7 \ ps$) show excellent signal-to-noise ratio (SNR)> 1000 for the low energy channel and SNR > 400 for the high energy channel.

KEYWORDS: Plasma diagnostics - interferometry, spectroscopy and imaging.

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1. Introduction

The interaction of a short pulse high intensity laser with solid targets leads to the generation of energetic electrons. The transport of these fast electrons and their isochoric heating of matter is of great interest to fast ignition [1, 2]. The flux of laser generated electrons is usually determined from the induced K-shell emission using doped targets [3] or tracer layer techniques [4]. When the electron beam propagates through the target, K-shell emission characteristic of dopant or tracer layer element is produced via electron impact ionization. The coupling efficiency of laser energy to these fast electrons and the energy deposited in the fuel can be inferred from transport models using the experimentally measured K_{α} yields [3, 5, 6].

The most widely used diagnostic for the absolute K-shell emission is a single hit CCD spectrometer [7]. However this diagnostic has a low dynamic range, does not always operate in the single-photon counting regime, and is susceptible to background and noise associated with high energy, high intensity experiments. Spherically bent Bragg imagers can also collect K_{α} emission and the absolute yield can be determined if the crystal reflectivity is known. The sensitivity of the collection efficiency to target temperature complicates the analysis and limits this technique to cold target where the temperature effects are negligible [8].

Mosaic graphite crystals have high reflectivity compared to other crystals and they have been used to collect weak signals in x-ray Thomson scattering experiments [9] and have also been

used to record K shell spectra in fast ignition experiments [5]. In fast ignition experiments, the interaction of kilojoule lasers with the target generates copious amount of noise and background radiation which can mask the desired signal. Shielding of the instrument is therefore important.

In this paper, we report on a newly developed dual channel x-ray spectrometer based on highly ordered pyrolytic graphite crystals. Our novel design uses an optimal configuration of crystals, detectors, and shielding to enhance the signal-to-noise ratio (SNR). This instrument has a high dynamic range and is capable of simultaneously detecting K-shell emission from two different tracer layers. The new design has the advantage of achieving mosaic focusing and excellent shielding of detectors from background radiation. The use of graphite crystals as dispersive optics and imaging plates as detectors gives high dynamic range. It eliminates the need to be in single photon counting regime, the plasma temperature effects, and failure of acquisition by CCD's associated with electromagnetic pulses (EMP).

2. Dual Channel HOPG Spectrometer (DC-HOPG) Description

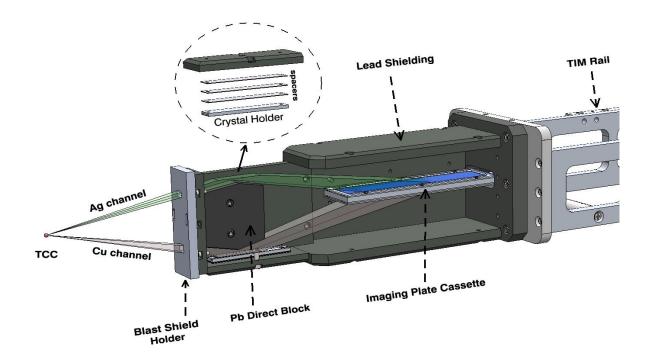


Figure 1. Dual Channel Highly Ordered Pyrolytic Graphite (DC-HOPG) layout

The Dual Channel HOPG Spectrometer (DC-HOPG) consists of two entrance slits, two crystals, a detector cassette, a removable blast shield, a direct light block, a Pb shielding enclosure, and alignment pin (Fig. 1). The design allows for two x-ray energy channels. A low energy "Cu channel" optimized for Cu K_{α} in first diffraction order and a high energy "Ag channel" optimized for Ag K_{α} in second diffraction order. X-rays emanating from the source enter the spectrometer via two entrance slits. The slits dimensions are chosen such that photon collection efficiency is maximized. The fan of rays entering the spectrometers via the slits fill the entire crystals thereby increasing the amount of photons collected in the non dispersive direction. The slits ensure that no

marginal rays are seen by the internal components of the instrument other than the crystals thereby minimizing background noise.

X-rays that satisfy the Bragg condition, $n\lambda = 2d \sin(\theta)$, are then diffracted with two highly ordered pyrolytic graphite crystals. The crystals are high purity graphite monochromators, ZYA grade with 0.4 degrees mosaic spread, purchased from Momentive Performance Materials Quartz, Inc. These crystals were mounted on adjustable, removable plates to allow for the use of various crystals and fine tuning of the instrument. The upper bound on the dimensions of the crystals that can be used are 3 inches in length and 0.5 inch in width. With 3 inch long crystals, the Bragg angles of x-rays diffracting from the center of the monochromators are 11.9 degrees for the Cu channel and 9.7 degrees for the Ag channel.

Table 1. List of some of the characteristic emission lines within the spectral range of the DC-HOPG

"Cu" Channel: E (eV)	"Ag" Channel: E (eV)
Ni $K_{\alpha 1,2} \to 7461, 7478$	Ru $K_{\alpha 1,2} \to 19150, 19279$
Cu $K_{\alpha 1,2} \to 8028, 8048$	Pd $K_{\alpha 1,2} \to 21020, 21177$
$\text{Zn } K_{\alpha 1,2} \to 8616, 8639$	Ag $K_{\alpha 1,2} \to 21990, 22163$
Ga $K_{\alpha 1,2} \rightarrow 9225, 9252$	Cd $K_{\alpha 1,2} \to 22984, 23174$
Ni $K_{\beta 1} \rightarrow 8265$	Ru $K_{\beta 1} \rightarrow 21657$
Cu $K_{eta 1} ightarrow 8905$	Pd $K_{eta1} ightarrow 23819$
$\operatorname{Zn} K_{\beta 1} o 9572$	Ag $K_{\beta 1} \rightarrow 24942$
Ga $K_{\beta 1} \rightarrow 10264$	$\operatorname{Cd} K_{\beta 1} o 26096$
Ni Heliumlike \rightarrow 7766, 8102	Ru Heliumlike \rightarrow 19717, 19904
Cu Heliumlike \rightarrow 8347, 8392	Pd Heliumlike \rightarrow 21622, 21843
Zn Heliumlike \rightarrow 8950, 8999	Ag Heliumlike \rightarrow 22609, 22851
Ga Heliumlike \rightarrow 9575, 9628	Cd Heliumlike \rightarrow 23621, 23884

Listed in table. 1 are some of the characteristic emission lines that can be detected, individually or simultaneously, with this instrument. The maximum achievable spectral range is,

$$7500 \ eV \le \frac{E}{n} \le 10500 \ eV, \ n \ge 1 \tag{2.1}$$

for the low energy channel and,

$$9500 \ eV \le \frac{E}{n} \le 13300 \ eV, \ n \ge 1 \tag{2.2}$$

for the high energy channel, where n is the diffraction order.

The x-ray spectra are recorded on two parallel imaging plates. The two imaging plates are separated by 5.3 mm thick Al plate to prevent the penetration of x-rays from one detector to the other. This thickness is more than sufficient to stop the high energy 22 keV Ag K_{α} which has 1.6 mm attenuation length in Al. The imaging plates are placed in a light tight cassette that can be easily removed and interchanged with a new one for the next shot. Both the imaging plate cassette and the slits are covered with 50 μm aluminized Mylar to ensure that no visible light reaches the detectors. The aluminized Mylar also protects the crystals from debris damage. A 7 cm long lead

block is placed between the source and imaging plates to prevents the direct beam from the source from reaching the detector. This configuration minimizes the exposure of detectors to hard x-rays and γ rays. The instrument is housed in a $\frac{1}{2}$ thick Pb body to protect it from background radiation generated during high power laser interaction with the targets.

3. Experimental setup

The qualification and flux calibration of the DC-HOPG were carried out on the Titan laser at Lawrence Livermore National Laboratory. Various flat targets were irradiated with either 150J delivered in 0.7 ps or 300 J delivered in 20 ps pulses. The laser beam irradiated the flat foils at angle of 16 degrees with respect to the normal (Fig. 2). The beam was focused with an f/3 off-axis parabola with 50% of the energy contained in $15\mu m$ fwhm spot. The spontaneous stimulated emission (ASE) contrast ratio was 10^{-8} in intensity and 10^{-4} in energy.

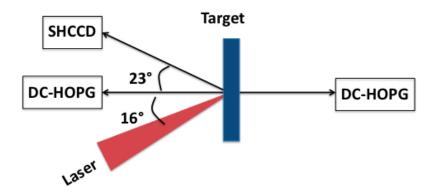


Figure 2. Experimental set up

Three instruments (Two DC-HOPGs and a single hit spectrometer) were fielded to detect x-ray emission from the target. The two DC-HOPGs were positioned along the normal to the target: one looking at the front (irradiated) side, the other at the rear side (Fig. 2). The distance from the target chamber center to the center of each crystal was 21cm. The single hit CCD spectrometer had a viewing angle of 23 degrees with respect to target normal.

4. Qualification and Performance of the DC-HOPG

4.1 Initial tests of the DC-HOPG on the Titan laser

4.1.1 The low energy channel

The Initial tests of the low energy channel of the DC-HOPG were carried out with 25 μm thick Cu targets. Fig. 3-a shows a typical spectrum from a Cu foil. Fig. 3-b and Fig. 3-c show the front and rear DC-HOPG lineouts. Clearly seen are the K_{α} and K_{β} emission lines corresponding to $1s \rightarrow 2p_{1/2}$ and $1s \rightarrow 2p_{3/2}$ transitions. In between we see the He_{α} and Ly_{α} thermal lines emitted by highly ionized Cu. The difference in thermal line intensities of rear and front spectra are due to opacity effects [10]. Cu targets oriented in such way that both instruments are looking at the

same side of the target showed that both DC-HOPGs recorded similar signals to within 5%. This indicates that the crystals used are of the same quality and have similar reflectivities. A lineout of K_{α} in the non-dispersive direction shows a fairly uniform profile with an average value of 44 and standard deviation of 4. This result will be used in the calibration process to simplify the integrated K_{α} yield calculations.

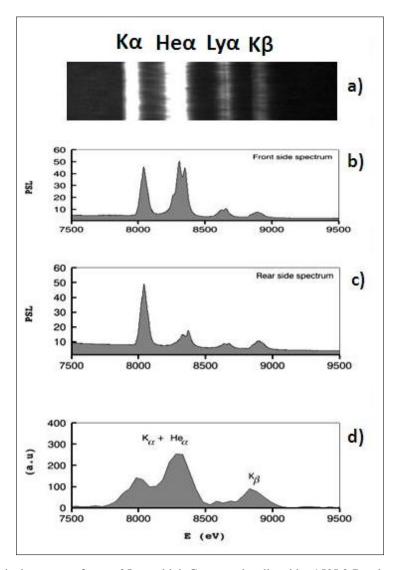


Figure 3. a) Typical spectrum from a 25 μm thick Cu target irradiated by 150J 0.7 ps laser beam, b) Front side DC-HOPG lineout, c) Rear side DC-HOPG lineout, d) A single hit CCD image histogram of similar target under similar irradiation conditions viewed from the front side.

We have compared the performance of the DC-HOPGs to that of the charged coupled devices (CCD) under the same experimental conditions. In addition to their linear response and dynamic range, CCDs have the advantage of electronic data acquisition. This is very convenient for immediate viewing and processing of data. However, our data show that CCDs are neither as reliable nor as useful as DC-HOPGs in acquiring data in high power laser experiments.

First, the single photon counting condition is only fulfilled for a limited dynamic range. In principle, this can be rectified for changing signal levels by changing the filtering and/or increasing the distance from target to detector. This is inconvenient in single shot experiments on large scale facility where every shot counts. Moreover, the single photon counting condition is highly dependent on both target type and irradiation conditions and there is no guarantee that if it is satisfied for one shot it will be satisfied for the next.

Second, due to its poor spectral resolution, the CCD cannot resolve the K_{α} and He_{α} emission lines. A comparison of the DC-HOPG spectrum (Fig. 3-b) and CCD image histogram (Fig. 3-c) clearly shows the advantage of the former over the later. A CCD histogram will overestimate K_{α} photon flux due to He_{α} contribution. The DC-HOPG spectrometer not only has the ability to resolve K_{α} and He_{α} , but also it can detect a wide range of emission lines. Intensity ratios, shifting, and broadening of these lines can be used to get valuable information about temperature and density of the plasma [8, 11].

Finally, high noise and failure of acquisition have been observed in our experiments for the CCDs, in contrast, the DC-HOPGs have been acquiring data reliably on every shot.

4.1.2 The high energy channel

In the case of Ag targets, only K_{α} and K_{β} emission line are recorded with both spectrometers (Fig. 4). The absence of thermal lines indicates that the high Z silver targets did not get hot enough for these lines to be emitted. The recorded Ag emission lines show much broader profiles compared to the Cu lines. Moreover, the Ag profiles exhibited an asymmetric behavior with features on the high energy side of the emission lines. This volumetric broadening is caused by the significant penetration depth of the photons [12].

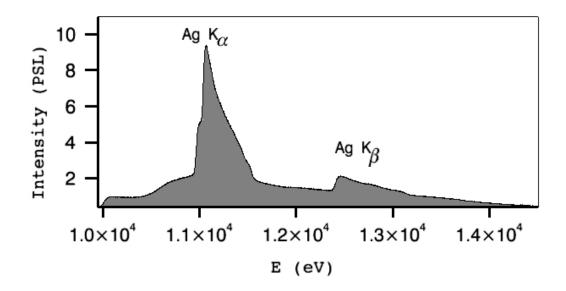


Figure 4. Typical Ag spectrum from a 12 μm thick Ag target irradiated by 150J 0.7 ps laser beam

4.2 Resolving power of the DC-HOPG

The factors affecting the resolution can be broadly classified as broadening due to the source, crystal, and detector. The observed spectral line is a convolution of the source broadened profile and the instrument function. The measured resolving power $\Delta E/E$ of the DC-HOPG is $7.46 \cdot 10^{-3}$ for Cu K_{α} and $1.22 \cdot 10^{-2}$ for Ag K_{α} . It can be expressed by the following quadrature sum,

$$\left[\frac{\Delta E}{E}\right]^{2} = \left[\frac{\Delta E}{E}\right]_{sr}^{2} + \left[\frac{\Delta E}{E}\right]_{nat}^{2} + \left[\frac{\Delta E}{E}\right]_{pl}^{2} + \left[\frac{\Delta E}{E}\right]_{mos}^{2} + \left[\frac{\Delta E}{E}\right]_{vol}^{2} + \left[\frac{\Delta E}{E}\right]_{rgh}^{2} + \left[\frac{\Delta E}{E}\right]_{det}^{2}$$
(4.1)

The first term in eq (1) refers to the effective source size effect. For a source size of 80 μm , determined from 2D spatially resolved K_{α} imaging, the source broadening is 20 eV and 42 eV for Cu K_{α} and Ag K_{α} respectively. The second term refers to the natural spectral width which is about 2 eV for Cu K_{α} lines [13] and 10 eV for Ag K_{α} [14]. The plasma source spectral distribution is complicated and depends on the local plasma characteristics. Several mechanisms contribute to the broadening and shifting of the emission lines. These include doppler, pressure, self-absorption, and ionization broadenings [11]. For our specific case of a 25 μm thick Cu foil irradiated by 150 J laser, doppler broadening is about 2.5 eV at a typical temperature of 300 eV. The radiative and plasma effects are small compared to the extended source effects and are neglected in subsequent analysis. The fourth, fifth, and sixth terms in eq (1) are the broadenings due to the mosaicity, depth, and surface roughness of the graphite crystal. Their effects on the resolution have been extensively discussed by [15, 16]. Ray tracing results specific to our spectrometer are summarized in the table below.

Table 2. Ray Tracing Results

Broadening	Cu $K_{\alpha}(\Delta E \ eV)$	$\Delta E/E$	Ag $K_{\alpha}(\Delta E \ eV)$	$\Delta E/E$
Source size	25	$2.485 \cdot 10^{-3}$	42	$1.668 \cdot 10^{-3}$
Mosaic	7.1	$8.722 \cdot 10^{-4}$	36.9	$1.098 \cdot 10^{-3}$
Depth	45	$5.881 \cdot 10^{-3}$	243.4	$1.373 \cdot 10^{-3}$
Roughness	7.9	$9.814 \cdot 10^{-4}$	30.4	$6.963 \cdot 10^{-4}$
Detector	4.1	$5.036 \cdot 10^{-3}$	15.4	$1.895 \cdot 10^{-3}$
Total	52.7	$6.537 \cdot 10^{-3}$	252.1	$1.137 \cdot 10^{-2}$

For the low energy channel, the effective source size and crystal depth contribute significantly to the broadening. The width of the Cu K_{α} line obtained with ray tracing was ~ 53 eV. This is consistent with the experimentally measured width of 56 eV. For the high energy channel, the dominant factor affecting the resolution is the crystal thickness. The experimentally measured fwhm of Ag K_{α} was 270 eV which is also consistent with ray tracing results. Our crystal thickness is ~ 2 mm and the resolution could be improved by using a thinner crystal $(100-200~\mu m)$ without significant loss of reflectivity $(8~keV \le E \le 24~keV)$ [17]. For our purpose, where the primary goal is to count K_{α} photons, the obtained resolution is enough. The spectrometer clearly resolves the K_{α} line from the adjacent He_{α} line.

4.3 Detector orientation and Mosaic focusing

An x-ray beam penetrating the crystal will encounter mosaic blocks such that the Bragg condition is satisfied for a given energy. This property leads to a focusing effect similar to the one in Bragg-Brentano geometry in powder diffraction [18]). This interesting effect, which is the consequence of crystallites in mosaic crystals, is known as mosaic focusing or parafocusing [15]. Glenzer et al (2003) have demonstrated, in the context of x-ray scattering experiments, that the crystal has to be equidistant from both source and detector in order for the mosaic focusing to be achieved. The orientation of the detector with respect to the diffracted rays does not contribute to the defocusing for single emission lines. However, if multiple lines are of interest as is the case in our experiments, the orientation of the detector is important. Fig. 5-a shows a configuration where the detector is normal to the diffracted rays. It is clear that in this setup, the source-crystal and crystal-detector are equal for one emission line (ray-1) but not for the other (ray-2). The defocusing effects will increase with increasing diffraction order and distances. Our design uses a detector parallel to the crystal (Fig. 5-b). In addition to the advantages that the detector is better shielded from background radiation, this configuration ensures point-to-point parafocusing.

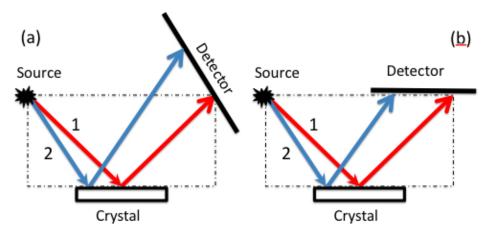


Figure 5. Detector orientation and mosaic focusing: a) Detector normal to the central diffracted ray (Red), b) Detector parallel to the crystal

4.4 Signal-to-noise ratio (SNR)

The signal-to-noise ratio was determined by taking the ratio of the background corrected peak signal to signal rms. A single pixel lineout analysis yields an average SNR \sim 225 for the low energy channel. However, since the Cu K_{α} emission line is fairly uniform in the non-dispersive direction, averaging over many pixels conserves the peak signal while the background noise is averaged. This results in an enhanced signal-to-noise ratio. For example, an average lineout using a box with 160 pixels in the non-dispersive direction yields an average SNR \sim 1000 (Table. 3). For the high energy channel, the signal-to-noise ratio was lower \sim 400 for a box average. This due to the fact that the slit is closer to the equatorial plane of laser-target interaction as the Bragg angle is

smaller for this channel. Also, the interaction of the laser beam with high Z targets generates more intense hard x-rays which contribute to background noise.

Table 3. SNR Results					
Shot	Peak	Sing. pix.	Sing. pix.	Box Aver.	Box Aver.
	signal	Stdev	SNR	Stdev	SNR
20080805-S1	73.9	0.158	467	0.062	1188
20080805-S2	36.4	0.184	198	0.024	1518
20080805-S3	49	0.252	195	0.034	1458
20080806-S1	40	0.276	144	0.095	420
20080806-S2	40	0.325	122	0.100	400
Average			225		1000

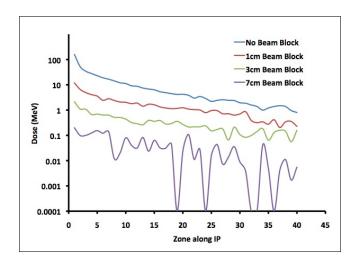


Figure 6. Dose deposited in the imaging plate as function of the zones for three different beam block thicknesses. Each zone is 257 μ m long

The excellent signal-to-noise ratio of the DC-HOPG is the result of an optimal shielding and detector positioning design. In addition to achieving point-to-point mosaic focusing, the horizontally positioned imaging plates are well shielded by the 7 cm long Pb block from direct radiation from the target. We have conducted Monte Carlo simulations of radiation transport through the Pb beam block using the Monte Carlo code Integrated Tiger Series 3.0 [19]. First, an electron distribution with 1.2 MeV average energy was injected into 250 μ m thick Ag target. Then, a sample size of 250,000,000 photons were generated in a 15 degree cone directed towards the beam block. The imaging plate has four layers: mylar, phosphor, mylar, and ferrite layer. Each imaging plate was divided into 400 zones and each zone was 350 μ m wide and 257 μ m long. After the transport through the Pb beam block, the simulation recorded the energy deposition in each zone of the phosphor layer. Three different beam block thicknesses were used: 1cm, 3cm, and 7cm. Fig. 6 shows the dose on the imaging plate averaged over the width of the detector. The 7 cm long beam block decreases the dose, due to background radiation, by a factor of 100 compared to the 1 cm

long beam block and by a factor of 1000 compared to no beam block. The $\frac{1}{2}''$ thick Pb housing of the instrument reduces the background radiation generated from the bulk of target chamber.

5. Absolute Calibration

The calibration of the DC-HOPG for photon flux was carried using a Spectral Instruments CCD. This camera was previously calibrated at 5.9 keV and 22 keV using Fe-55 and Cd-109 sources [20]. The SI800 CCD was located at a distance of 5.20 m at an angle of 23 degrees with respect to the normal to the front surface of the target. For the low energy channel we have used $5\mu m$ Al/25 μm Cu targets. The Cu K_{α} yields from both instruments are listed in Table. 4.

Table 4. Calibration Shots Results

Shot	Laser Energy (J)	DC-HOPG $(PSL.eV/J/sr)$	SHCCD (ph/J/sr)
20090803-S5	123	2.57×10^{6}	6.17×10^9
20090803-S6	310	3.75×10^{6}	1.36×10^{10}

For the SHCCD spectrometer, the number of K_{α} photons normalized to laser energy and detector solid angle (ph/J/sr) is determined by the following expression,

$$N_{CCD} = \frac{\int h(E) dE}{E_L \cdot \varepsilon_{CCD} \cdot T_{filters} \cdot \Omega_{image}} \kappa_{op}$$
 (5.1)

Where h(E) is the background subtracted histogram of the CCD image, E_L is the laser energy in Joules, ε_{CCD} is the product of the quantum efficiency, single hit probability, and crowding correction, $T_{filters}$ is the transmission of all the filters (including Be windows), Ω_{image} is the solid angle of the detector, and κ_{op} is the opacity correction along the line of sight due to reabsorption of the K_{α} emission in the target.

For the DC-HOPG, the number of K_{α} photons normalized to laser energy and detector solid angle (PSL.eV/J/sr) can be determined according to the following expression,

$$N_{DC-HOPG} = \frac{\kappa_{op}}{E_L \cdot \Omega_{det}} \iint_D f(x, y) \, dx dy$$
 (5.2)

Where f(x,y) is the background subtracted 2D K_{α} emission profile recorded by the detector. D is a region that includes the K_{α} line, its transverse size can be chosen as convenient while its longitudinal extent (in the dispersion direction) is determined by the mosaic spread of the crystal.

In the DC-HOPGs, we used BAS- MS 2040 imaging plates as detectors. After data aqcuisition, the imaging plates were scanned with Fuji FLA7000 scanner. The digitized images were then converted to Photo Stimulated Luminescence units (PSL) using the following formula (Fuji manuel),

$$PSL = \left\lceil \frac{Res}{100} \right\rceil^2 \cdot \frac{4000}{S} \cdot 10^{L \left\lceil \frac{QL}{G} - \frac{1}{2} \right\rceil}$$
 (5.3)

Our scanning parameters were $50\mu m$ for resolution (Res), 4000 for sensitivity (S), 5 for Latitude (L), 65535 for gradation (G), and a range of 0 to 65535 for QL. The PSL converted images are two

dimensional of the form f(x,y). Since, as mentioned previously, emission lines are fairly uniform in the non-dspersive (x) direction, eq.(5) can be written as,

$$N_{DC-HOPG} = \frac{\kappa_{op}}{E_L \cdot \Omega_{pix}} \int f(E) dE$$
 (5.4)

where Ω_{pix} is the single pixel lineout solid angle. f(E) is the average lineout of the K_{α} line obtained after transforming the coordinate space (y) to energy space using the dispersion expression,

$$\frac{\Delta E}{\Delta y} = \frac{E}{2F \cdot tan(\theta)}, F - source \ to \ crystal \ distance \tag{5.5}$$

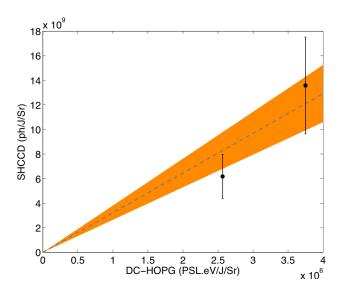


Figure 7. Calibration curve: The dashed line is the calibration curve, the yellow region represents the error in the best fit to the two experimental data points

For a set of data $\{X_i, Y_i\}$, where the X_i and Y_i are the DC-HOPG and SHCCD yields from Table. 4, we seek a weighted least square fit straight line Y = AX. The constant A is the calibration factor which includes the reflectivity of the crystal, filter transmissions, and the response of the imaging plate to x-rays. This constant is determined from the data by minimizing the χ^2 ,

$$\frac{\partial \chi^2}{\partial A} = \frac{\partial}{\partial A} \sum_i \frac{1}{\sigma_i^2} \{ Y_i - A X_i \}^2 = 0$$
 (5.6)

which gives,

$$A = 3.23 \times 10^3 \pm 18\% \tag{5.7}$$

The calibration curve is plotted in Fig. 7. The dashed line is the calibration curve ($Y = 3.23 \times 10^3 \times X$). The yellow band represents the error in least square data fit. For the high energy channel calibration, we have used Al targets with a $25\mu m$ Ag thick layer. Similar analysis yields a calibration constant $A = 6.69 \times 10^3 \pm 50\%$.

6. Conclusion

In conclusion, we have developed an x-ray spectrometer for fast ignition research. It has low and high energy channels. This instrument is compact and has the advantage of flexibility in the choice of tracer or dopant materials due to the wide spectral range of both channels. The orientation of the imaging plates with respect to the crystals allows point-to-point mosaic focusing to be achieved. The location of the imaging plates and the optimal shielding of the instrument enhances the signal-to-noise ratio. The qualification of the DC-HOPG on the Titan laser shows a SNR> 1000 with Cu foils and SNR> 400 for Ag targets. The DC-HOPG is absolutely calibrated and its spectral resolution is suitable for the study of laser-generated electrons in the context of fast ignition.

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